# Notice of References Cited

Application/Control No.

10/782,570

Examiner

Anne R. Kubelik

Applicant(s)/Patent Under
Reexamination
CAROZZI ET AL.

Art Unit
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## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
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### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U	Aaronson et al, 2001, FEMS Microbiol. Lett. 195:1-8		
	v	De Maagd et al, 2001, Trends Genet. 17:193-199		
*	w	Jenkins et al. (1999) FEBS Letters 462:373-376		
*	x	Rajamohan et al. (1996) J Biol. Chem. 271 (41) :25220-25226		

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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	Α	US-			
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	R					
	S					
	Т			-		

### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
*	U	Lee et al. (2001) FEBS Letters 497:108-112			
*	V	Schwartz et al. (1997) Appl. Environ. Microbiol. 63(10): 3978-3984			
*	w	Masson et al. (2002) Appl. Environ. Microbiol. 68(1):194-200			
	x	Schnepf et al 1998 Microbiol, Md. Biol. Rev. 62:775-806			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.